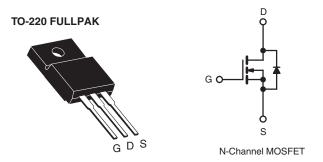


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	100			
$R_{DS(on)}(\Omega)$	$V_{GS} = 5 V$	0.27		
Q _g (Max.) (nC)	12			
Q _{gs} (nC)	3.0			
Q _{gd} (nC)	7.1			
Configuration	Single			



FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)



RoHS*

- Sink to Lead Creepage Distance = 4.8 mm
- Logic-Level Gate Drive
- R_{DS (on)} Specified at V_{GS} = 4 V and 5 V
- Fast Switching
- Ease of Paralleling
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRLI520GPbF
Lead (PD)-liee	SiHLI520G-E3
SnPb	IRLI520G
	SiHLI520G

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	100	V	
Gate-Source Voltage			V _{GS}	± 10	V	
Continuous Drain Current	V _{GS} at 5 V	T _C = 25 °C	- I _D	7.2		
	VGS at 5 V	T _C = 100 °C		5.1	Α	
Pulsed Drain Current ^a			I _{DM}	29		
Linear Derating Factor				0.24	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	170	mJ	
Repetitive Avalanche Current ^a			I _{AR}	7.2	Α	
Repetitive Avalanche Energy ^a			E _{AR}	3.7	mJ	
Maximum Power Dissipation	T _C = 25 °C		P _D	37	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	- °C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Forque				1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 4.9 \,\text{mH}$, $R_G = 25 \,\Omega$, $I_{AS} = 7.2 \,\text{A}$ (see fig. 12).
- c. $I_{SD} \le 9.2$ A, $dI/dt \le 110$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.
- * Pb containing terminations are not RoHS compliant, exemptions may apply

IRLI520G, SiHLI520G

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	4.1	C/VV	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	100	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	Reference to 25 °C, I _D = 1 mA			-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		-	2.0	٧
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 10 V		-	± 100	nA
Zava Cata Valtaga Drain Current	1	V _{DS} = 100 V, V _{GS} = 0 V		-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80 V,	V _{GS} = 0 V, T _J = 150 °C	-	-	250	μΑ
Dunin Course On Otata Basistana	Ъ	V _{GS} = 5 V	I _D = 4.3 A ^b	-	-	0.27	Ω
Drain-Source On-State Resistance	R _{DS (on)}	V _{GS} = 4 V	I _D = 3.6 A ^b	-	-	0.38	
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D = 4.3 A ^b	3.3	-	-	S
Dynamic				•		•	
Input Capacitance	C _{iss}		V = 0 V		490	-	pF
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. 5}$ $f = 1.0 \text{ MHz}$		-	150	-	
Reverse Transfer Capacitance	C _{rss}			-	30	-	
Drain to Sink Capacitance	С			-	12	-	
Total Gate Charge	Qg			-	-	12	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 5 V	$I_D = 9.2 \text{ A}, V_{DS} = 80 \text{ V},$ see fig. 6 and 13 ^b	-	-	3.0	
Gate-Drain Charge	Q _{gd}		See lig. 6 and 16	-	-	7.1	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 50 \text{ V}, I_D = 9.2 \text{ A},$ $R_G = 9 \Omega, R_D = 5.2 \Omega,$ see fig. 10^b		-	9.8	-	- ns
Rise Time	t _r			-	64	-	
Turn-Off Delay Time	t _{d(off)}			-	21	-	
Fall Time	t _f			-	27	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	- nH
Internal Source Inductance	L _S			-	7.5	-	
Drain-Source Body Diode Characteristic	s			·		!	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	7.2	- A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	29	
Body Diode Voltage	V _{SD}	T_J = 25 °C, I_S = 7.2 A, V_{GS} = 0 V^b		-	-	2.5	٧
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 9.2 A, dl/dt = 100 A/μs ^b		-	130	190	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.83	1.0	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	on is don	ninated b	v L _S and I	Ln)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

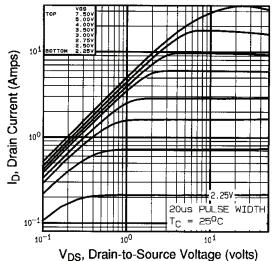


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

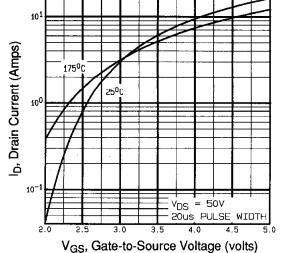


Fig. 3 - Typical Transfer Characteristics

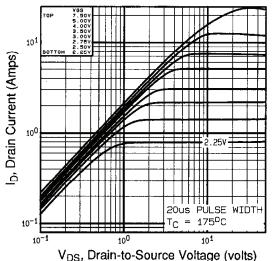


Fig. 2 - Typical Output Characteristics, $T_C = 175$ °C

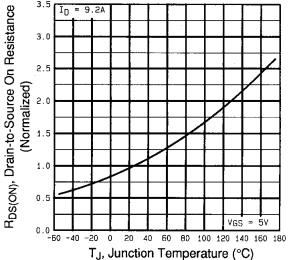


Fig. 4 - Normalized On-Resistance vs. Temperature

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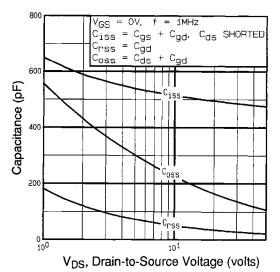


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

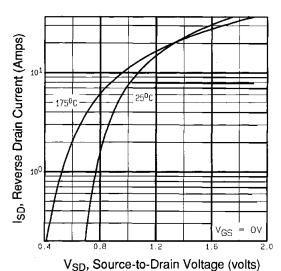


Fig. 7 - Typical Source-Drain Diode Forward Voltage

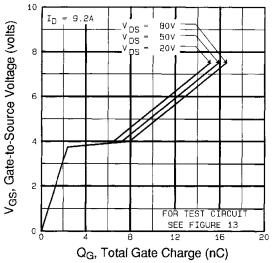


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

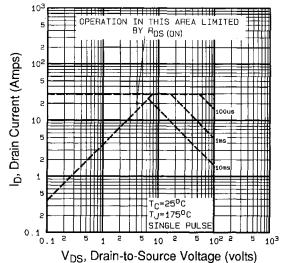


Fig. 8 - Maximum Safe Operating Area





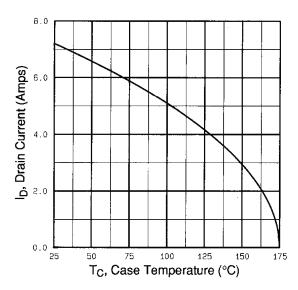


Fig. 9 - Maximum Drain Current vs. Case Temperature

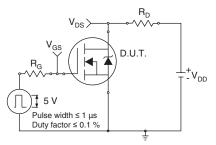


Fig. 10a - Switching Time Test Circuit

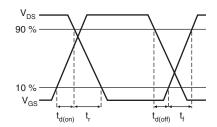


Fig. 10b - Switching Time Waveforms

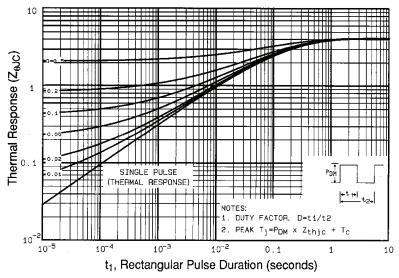


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

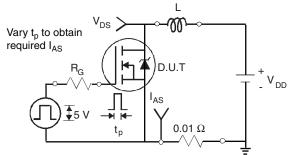


Fig. 12a - Unclamped Inductive Test Circuit

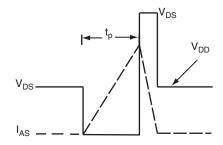


Fig. 12b - Unclamped Inductive Waveforms

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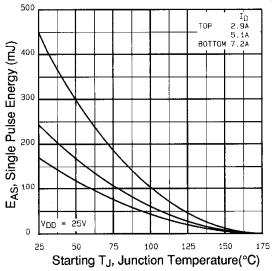


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

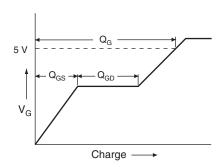


Fig. 13a - Basic Gate Charge Waveform

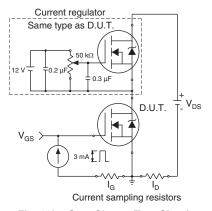
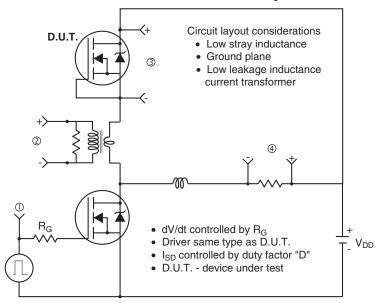
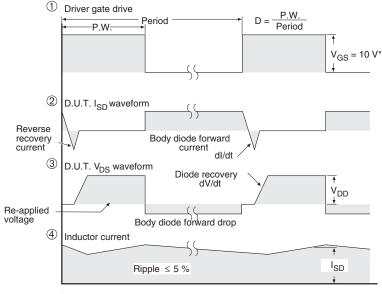


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* $V_{GS} = 5 V$ for logic level devices

Fig.14 - For N-Channel

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